

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination KOGA, HIROKI	
			Examiner Thao X Le	Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,521,963	02-2003	Ota et al.	257/412
	B	US-5,985,712	11-1999	Ooishi, Mitsuma	438/231
	C	US-6,573,132	06-2003	Uehara et al.	438/211
	D	US-6,236,093	05-2001	Hiura, Yohei	257/413
	E	US-6,518,636	02-2003	Segawa et al.	257/411
	F	US-5,472,896	12-1995	Chen et al.	438/305
	G	US-6,342,422	01-2002	Wu, Shye-Lin	438/300
	H	US-6,448,140	09-2002	Liaw, Jhon-Jhy	438/279
	I	US-6,136,636	10-2000	Wu, Shye-Lin	438/231
	J	US-6,083,816	07-2000	Kanamori, Jun	438/585
	K	US-5,654,570	08-1997	Agnello, Paul David	257/338
	L	US-6,162,741	12-2000	Akasaka et al.	438/773
	M	US-6,096,595	08-2000	Huang, Jenn Ming	438/238

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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